



# RF Power LDMOS Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

These RF power transistors are designed for applications operating at frequencies between 960 and 1215 MHz such as distance measuring equipment (DME), transponders and secondary radars for air traffic control. These devices are suitable for use in pulse applications, including Mode S ELM.

- Typical Pulse Performance:  $V_{DD} = 50$  Volts,  $I_{DQ} = 200$  mA

Application	Signal Type	$P_{out}^{(1)}$ (W)	Freq. (MHz)	$G_{ps}$ (dB)	$\eta_D$ (%)
Narrowband Short Pulse	Pulse (128 $\mu$ sec, 10% Duty Cycle)	500 Peak	1030	19.7	62.0
Narrowband Mode S ELM	Pulse (48 $\times$ (32 $\mu$ sec on, 18 $\mu$ sec off), Period 2.4 msec, 6.4% Long-term Duty Cycle)	500 Peak	1030	19.7	62.0
Broadband	Pulse (128 $\mu$ sec, 10% Duty Cycle)	500 Peak	960-1215	18.5	57.0

1. Minimum output power for each specified pulse condition.

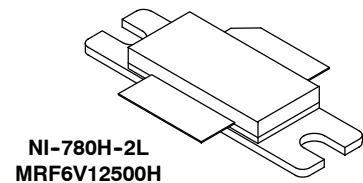
- Capable of Handling 10:1 VSWR @ 50 Vdc, 1030 MHz, 500 Watts Peak Power

### Features

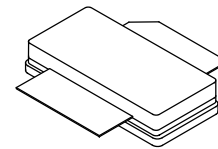
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified up to a Maximum of 50  $V_{DD}$  Operation
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation

**MRF6V12500H**  
**MRF6V12500HS**  
**MRF6V12500GS**

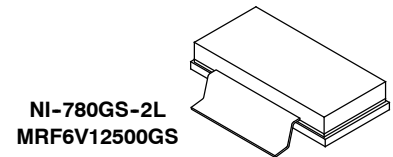
**960-1215 MHz, 500 W, 50 V**  
**PULSE**  
**RF POWER LDMOS TRANSISTORS**



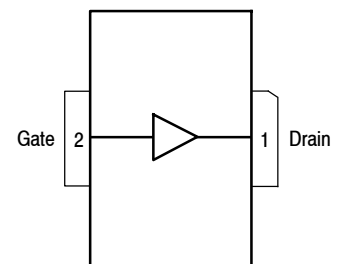
**NI-780H-2L**  
**MRF6V12500H**



**NI-780S-2L**  
**MRF6V12500HS**



**NI-780GS-2L**  
**MRF6V12500GS**



(Top View)

Note: The backside of the package is the source terminal for the transistor.

**Figure 1. Pin Connections**



**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +110	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_C$	150	°C
Operating Junction Temperature (1,2)	$T_J$	225	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (2,3)	Unit
Thermal Impedance, Junction to Case Case Temperature 80°C, 500 W Peak, 128 $\mu$ sec Pulse Width, 10% Duty Cycle	$Z_{\theta JC}$	0.044	°C/W

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2600 V
Machine Model (per EIA/JESD22-A115)	B, passes 200 V
Charge Device Model (per JESD22-C101)	IV, passes 2000 V

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

**Off Characteristics**

Gate-Source Leakage Current ( $V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc)	$I_{GSS}$	—	—	10	$\mu$ Adc
Drain-Source Breakdown Voltage ( $V_{GS} = 0$ Vdc, $I_D = 200$ mA)	$V_{(BR)DSS}$	110	—	—	Vdc
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 50$ Vdc, $V_{GS} = 0$ Vdc)	$I_{DSS}$	—	—	20	$\mu$ Adc
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 90$ Vdc, $V_{GS} = 0$ Vdc)	$I_{DSS}$	—	—	200	$\mu$ Adc

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10$ Vdc, $I_D = 1.32$ mA)	$V_{GS(th)}$	0.9	1.7	2.4	Vdc
Gate Quiescent Voltage ( $V_{DD} = 50$ Vdc, $I_D = 200$ mA, Measured in Functional Test)	$V_{GS(Q)}$	1.7	2.4	3.2	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10$ Vdc, $I_D = 3.26$ Adc)	$V_{DS(on)}$	—	0.25	—	Vdc

**Dynamic Characteristics (4)**

Reverse Transfer Capacitance ( $V_{DS} = 50$ Vdc $\pm$ 30 mV(rms)ac @ 1 MHz, $V_{GS} = 0$ Vdc)	$C_{rss}$	—	0.2	—	pF
Output Capacitance ( $V_{DS} = 50$ Vdc $\pm$ 30 mV(rms)ac @ 1 MHz, $V_{GS} = 0$ Vdc)	$C_{oss}$	—	697	—	pF
Input Capacitance ( $V_{DS} = 50$ Vdc, $V_{GS} = 0$ Vdc $\pm$ 30 mV(rms)ac @ 1 MHz)	$C_{iss}$	—	1391	—	pF

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.
4. Part internally matched both on input and output.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Functional Tests</b> (In Freescale Narrowband Test Fixture, 50 ohm system) $V_{DD} = 50\text{ Vdc}$ , $I_{DQ} = 200\text{ mA}$ , $P_{out} = 500\text{ W Peak}$ (50 W Avg.), $f = 1030\text{ MHz}$ , 128 $\mu\text{sec}$ Pulse Width, 10% Duty Cycle					
Power Gain	$G_{ps}$	18.5	19.7	22.0	dB
Drain Efficiency	$\eta_D$	58.0	62.0	—	%
Input Return Loss	IRL	—	-18	-9	dB

**Typical Broadband Performance — 960-1215 MHz** (In Freescale 960-1215 MHz Test Fixture, 50 ohm system)  $V_{DD} = 50\text{ Vdc}$ ,  $I_{DQ} = 200\text{ mA}$ ,  $P_{out} = 500\text{ W Peak}$  (50 W Avg.),  $f = 960\text{-}1215\text{ MHz}$ , 128  $\mu\text{sec}$  Pulse Width, 10% Duty Cycle

Power Gain	$G_{ps}$	—	18.5	—	dB
Drain Efficiency	$\eta_D$	—	57.0	—	%

**Table 5. Ordering Information**

Device	Tape and Reel Information	Package
MRFE6V12500HR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	NI-780H-2L
MRFE6V12500HSR5		NI-780S-2L
MRFE6V12500GSR5		NI-780GS-2L

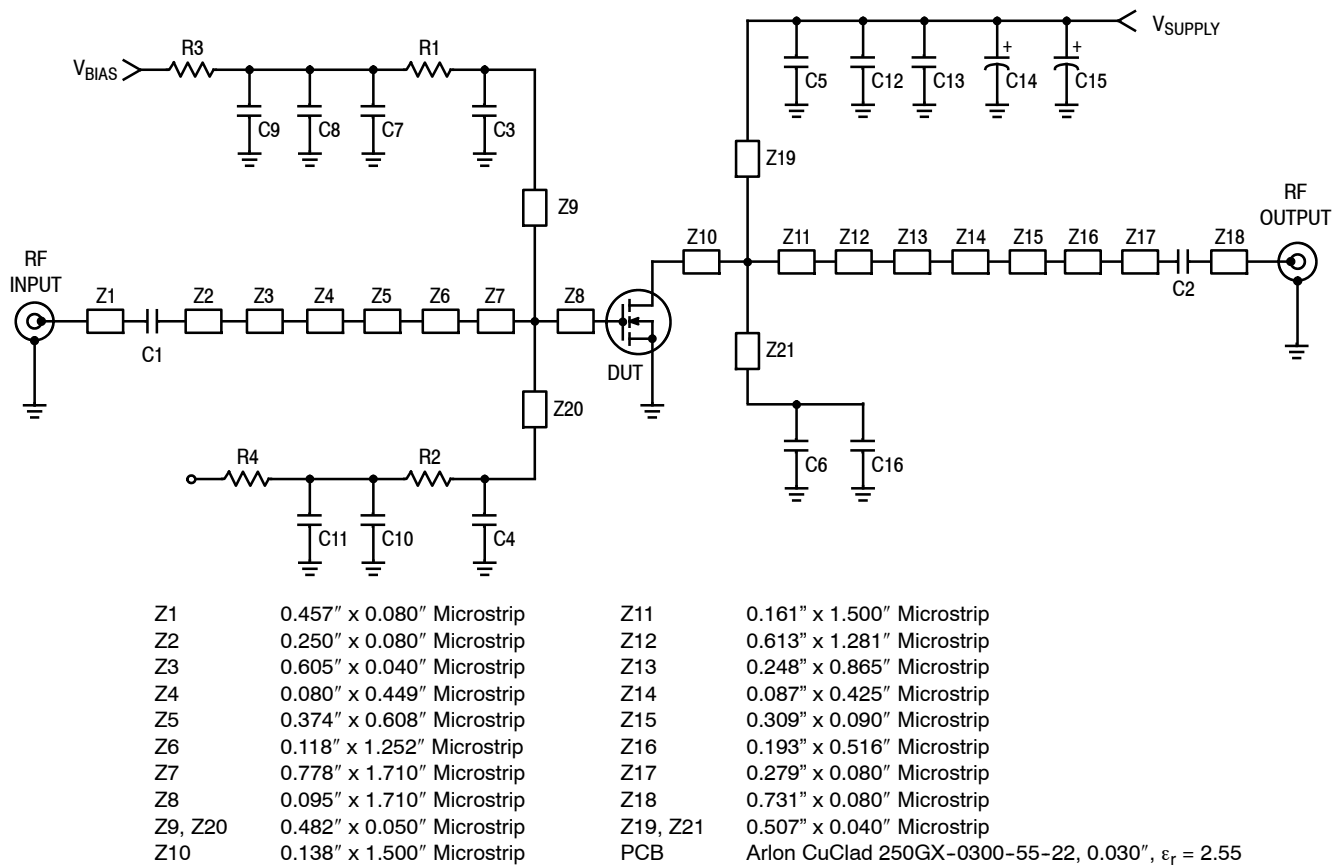


Figure 2. MRF6V12500H(HS) Test Circuit Schematic

Table 6. MRF6V12500H(HS) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2	5.1 pF Chip Capacitors	ATC100B5R1CT500XT	ATC
C3, C4, C5, C6	33 pF Chip Capacitors	ATC100B330JT500XT	ATC
C7, C10	10 $\mu$ F, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C8, C11, C13, C16	2.2 $\mu$ F, 100 V Chip Capacitors	2225X7R225KT3AB	ATC
C9	22 $\mu$ F, 25 V Chip Capacitor	TPSD226M025R0200	AVX
C12	1 $\mu$ F, 100 V Chip Capacitor	GRM31CR72A105KA01L	Murata
C14, C15	470 $\mu$ F, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
R1, R2	56 $\Omega$ , 1/4 W Chip Resistors	CRCW120656R0FKEA	Vishay
R3, R4	0 $\Omega$ , 3 A Chip Resistors	CRCW12060000Z0EA	Vishay

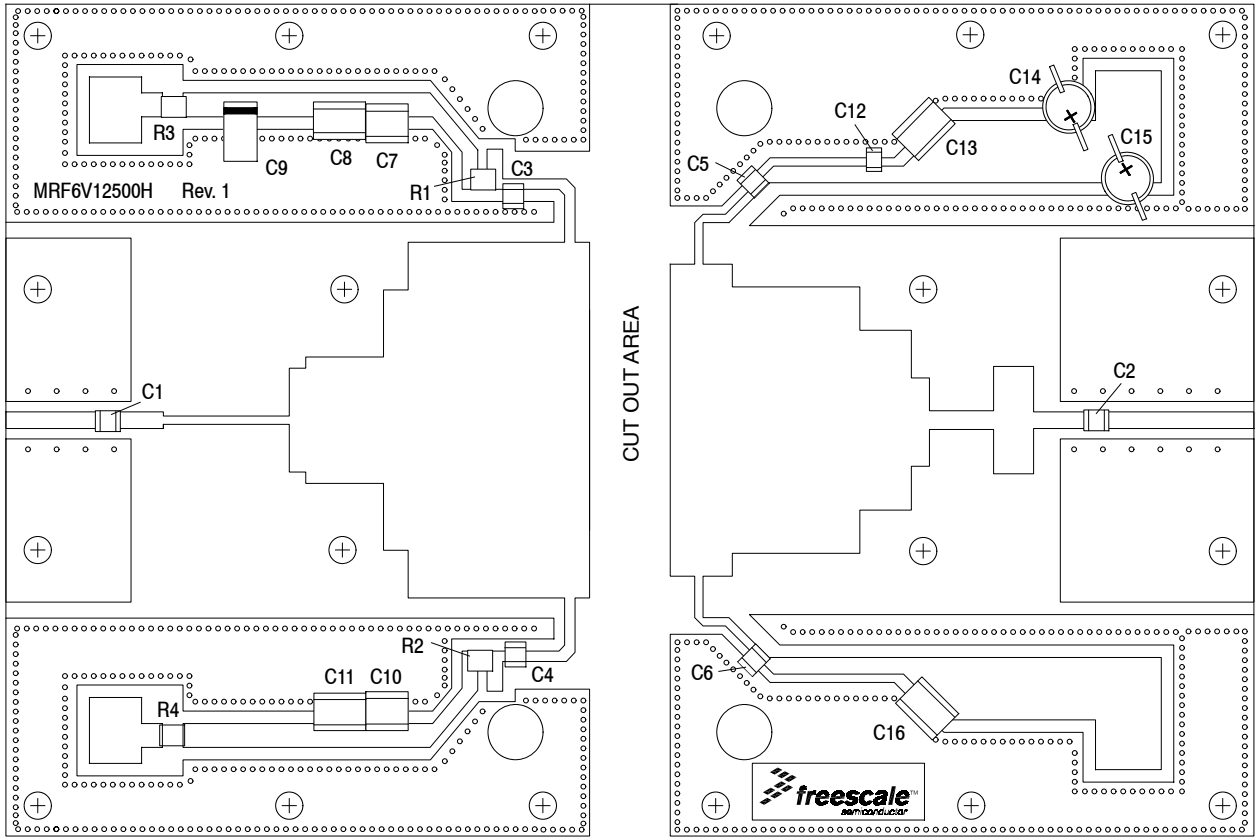


Figure 3. MRF6V12500H(HS) Test Circuit Component Layout

## TYPICAL CHARACTERISTICS

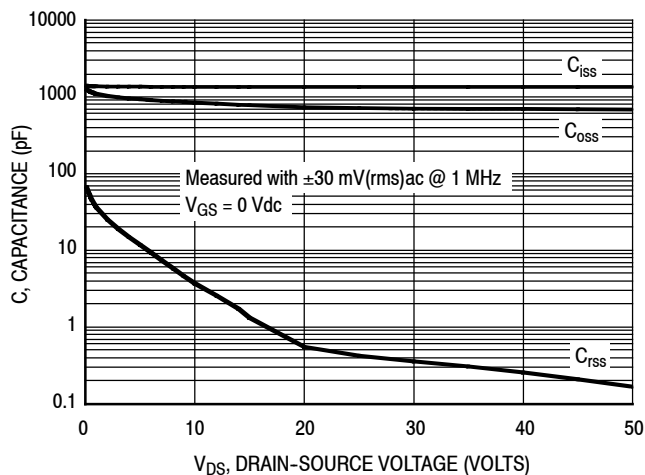


Figure 4. Capacitance versus Drain-Source Voltage

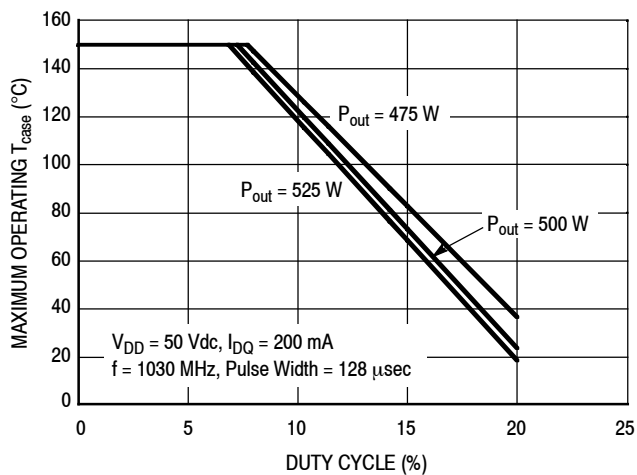


Figure 5. Safe Operating Area

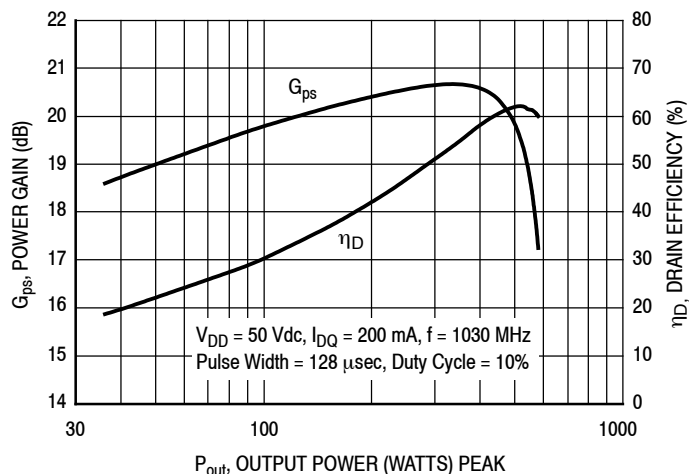


Figure 6. Power Gain and Drain Efficiency versus Output Power

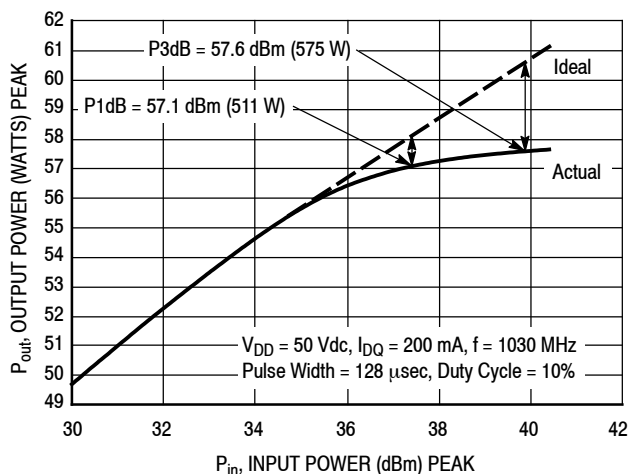


Figure 7. Output Power versus Input Power

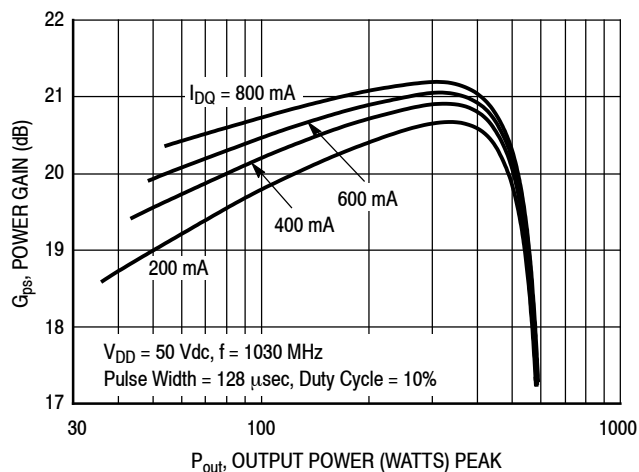


Figure 8. Power Gain versus Output Power

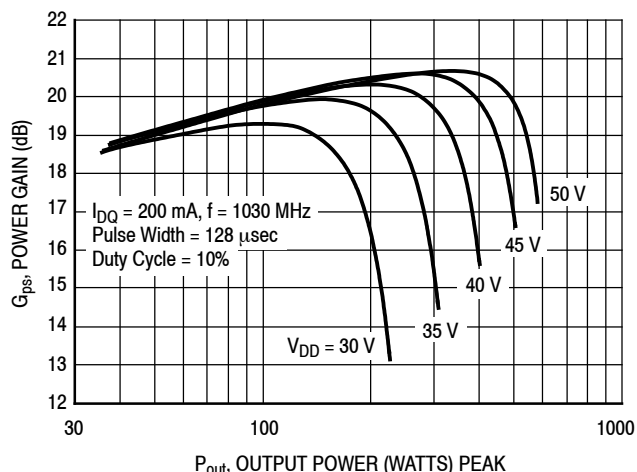


Figure 9. Power Gain versus Output Power

## TYPICAL CHARACTERISTICS

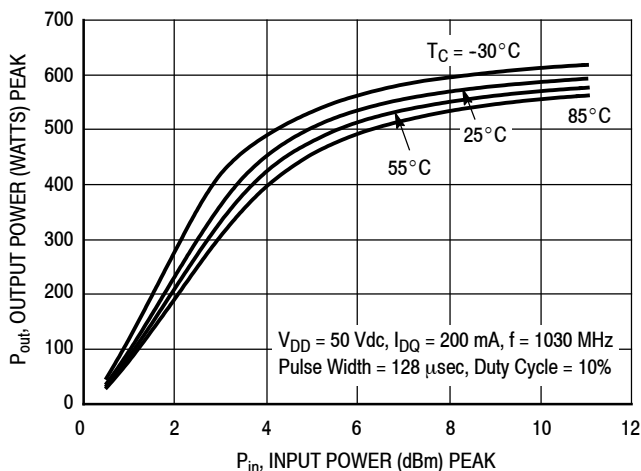


Figure 10. Output Power versus Input Power

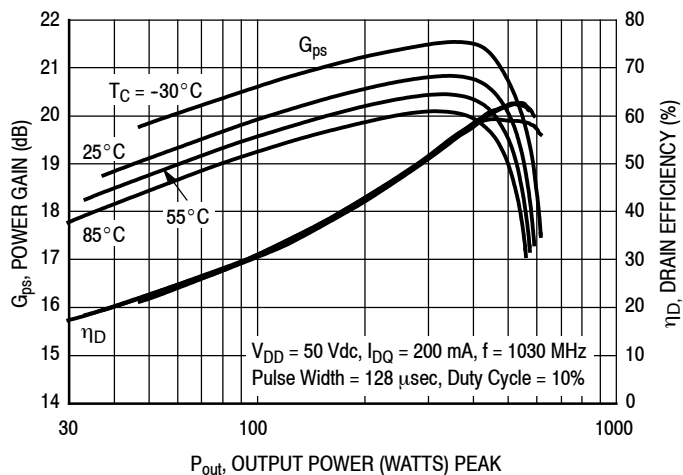
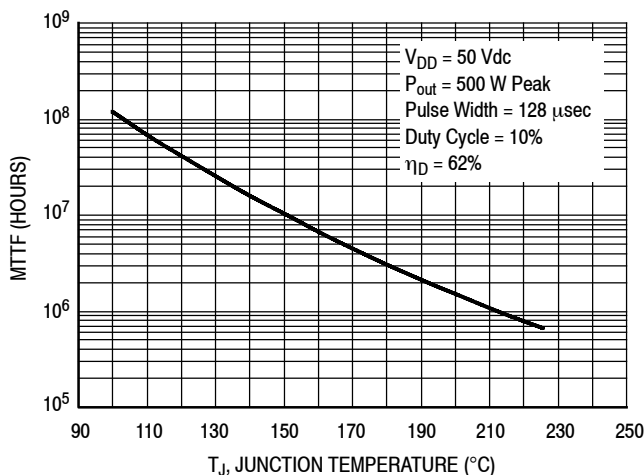


Figure 11. Power Gain and Drain Efficiency versus Output Power



**Note:** MTTF value represents the total cumulative operating time under indicated test conditions.

MTTF calculator available at <http://www.nxp.com/RF/calculators>.

Figure 12. MTTF versus Junction Temperature

$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 200 \text{ mA}$ ,  $P_{out} = 500 \text{ W Peak}$

f MHz	$Z_{source}$ Ω	$Z_{load}$ Ω
1030	$1.36 - j1.27$	$2.50 - j0.17$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

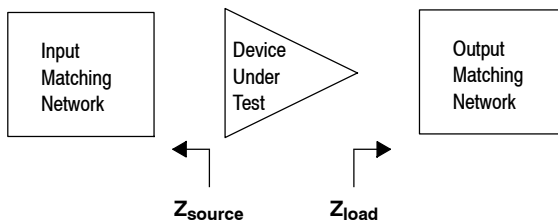


Figure 13. Series Equivalent Source and Load Impedance

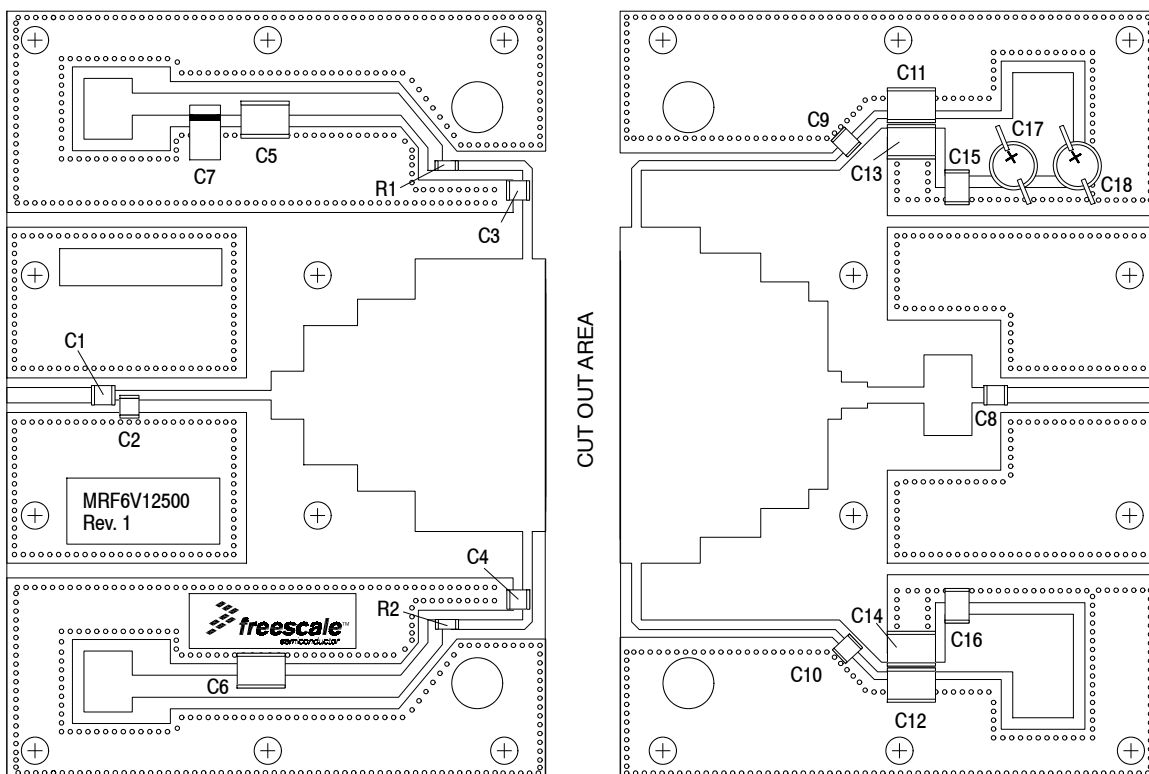


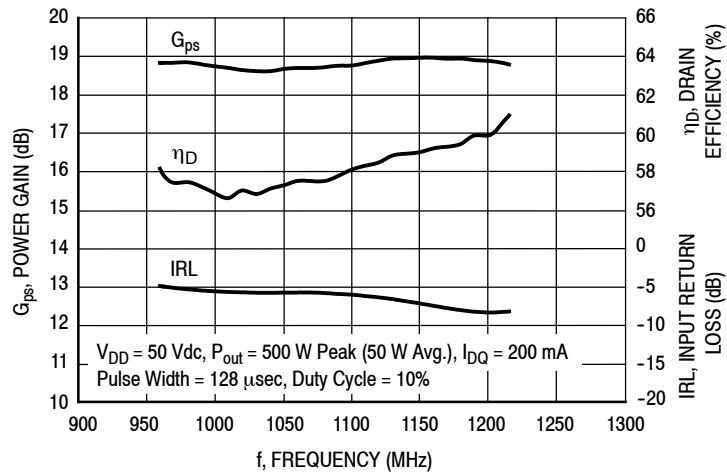
Figure 14. MRF6V12500H(HS) Test Circuit Component Layout — 960-1215 MHz

Table 7. MRF6V12500H(HS) Test Circuit Component Designations and Values — 960-1215 MHz

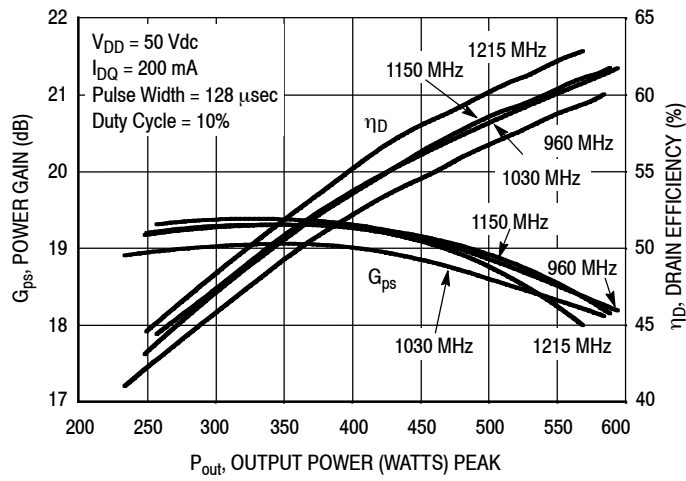
Part	Description	Part Number	Manufacturer
C1	2.2 pF Chip Capacitor	ATC100B2R2JT500XT	ATC
C2	0.2 pF Chip Capacitor	ATC100B0R2BT500XT	ATC
C3, C4	33 pF Chip Capacitors	ATC100B330JT500XT	ATC
C5, C6, C11, C12	2.2 $\mu$ F, 100 V Chip Capacitors	G2225X7R225KT3AB	ATC
C7	22 $\mu$ F, 35 V Tantalum Capacitor	T491X226K035AT	Kemet
C8	8.2 pF Chip Capacitor	ATC100B8R2CT500XT	ATC
C9, C10	39 pF Chip Capacitors	ATC100B390JT500XT	ATC
C13, C14	0.022 $\mu$ F, 100 V Chip Capacitors	C1825C223K1GAC	Kemet
C15, C16	0.10 $\mu$ F, 100 V Chip Capacitors	C1812F104K1RAC	Kemet
C17, C18	470 $\mu$ F, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
R1, R2	22 $\Omega$ , 1/4 W Chip Resistors	CRCW120622R0FKEA	Vishay
PCB	0.030", $\epsilon_r = 2.55$	AD255A	Arlon



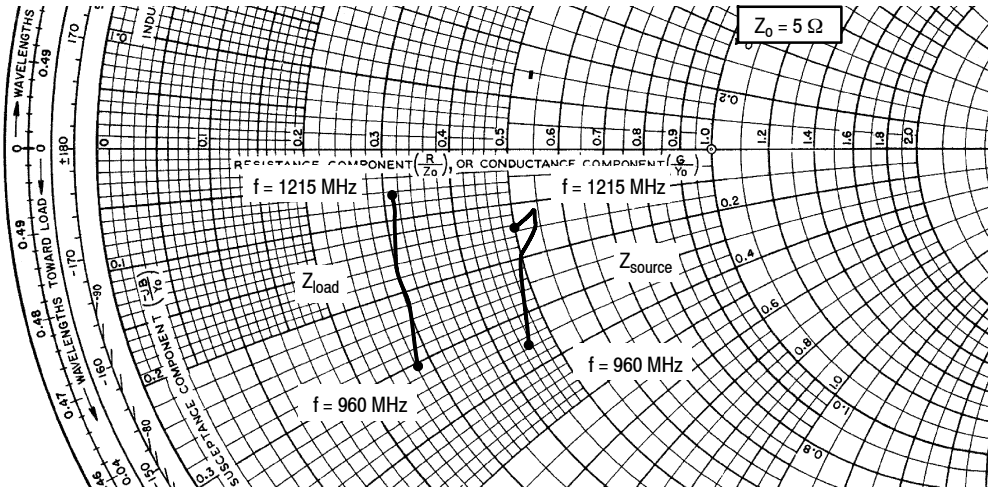
### TYPICAL CHARACTERISTICS — 960-1215 MHz



**Figure 15. Power Gain, Drain Efficiency and IRL versus Frequency**



**Figure 16. Power Gain and Drain Efficiency versus Output Power**



$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 200 \text{ mA}$ ,  $P_{out} = 500 \text{ W Peak}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
960	$2.25 - j1.78$	$1.38 - j1.53$
1030	$2.51 - j1.02$	$1.48 - j1.11$
1090	$2.69 - j0.73$	$1.51 - j0.78$
1150	$2.71 - j0.65$	$1.53 - j0.49$
1215	$2.48 - j0.76$	$1.53 - j0.33$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

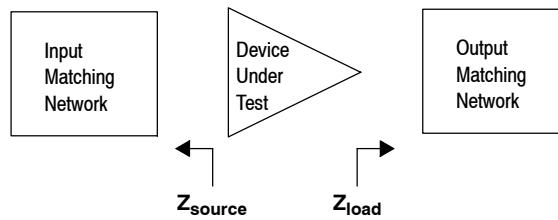
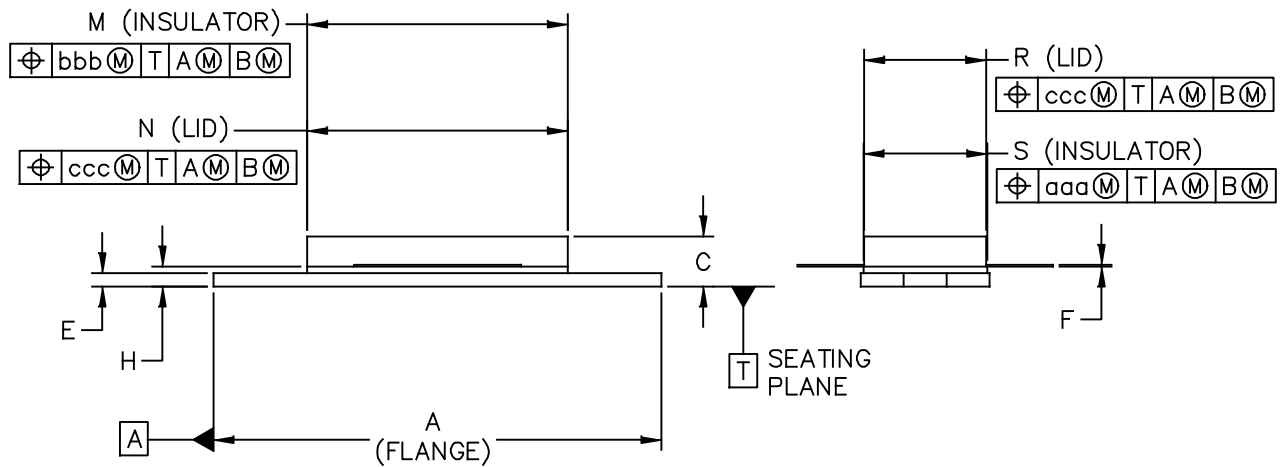
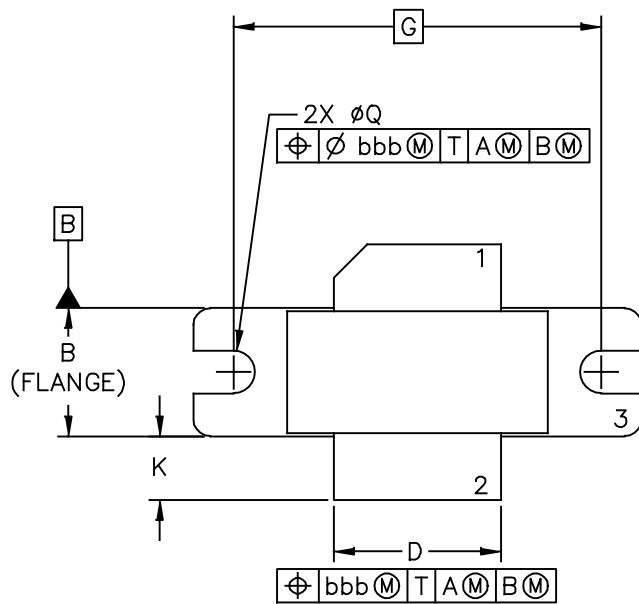


Figure 17. Series Equivalent Source and Load Impedance — 960-1215 MHz

## PACKAGE DIMENSIONS



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DOCUMENT NO: 98ASB15607C	REV: H							
STANDARD: NON-JEDEC								
SOT1792-1	14 MAR 2016							

**MRF6V12500H MRF6V12500HS MRF6V12500GS**

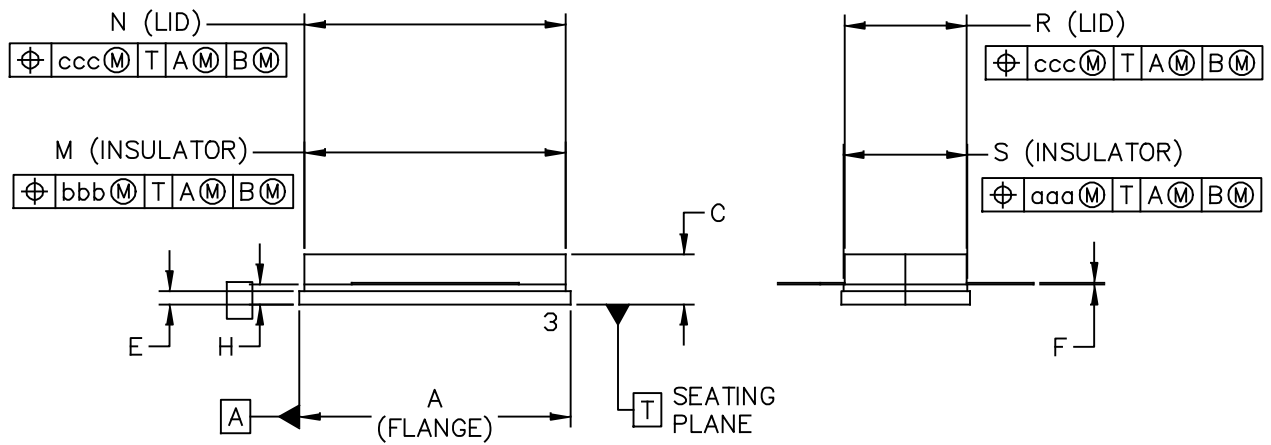
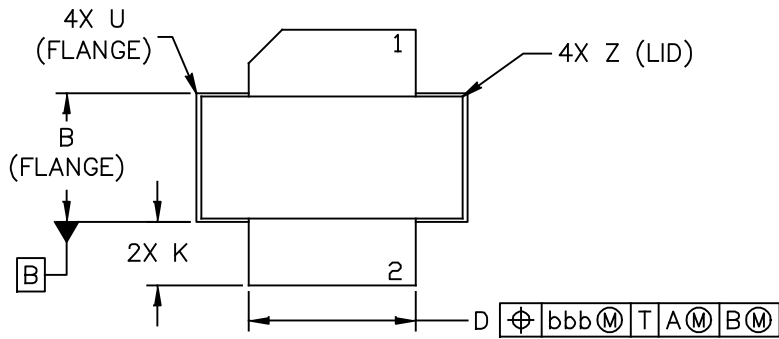
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN  
 2. GATE  
 3. SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.335	– 1.345	33.91	– 34.16	R	.365	– .375	9.27	– 9.53
B	.380	– .390	9.65	– 9.91	S	.365	– .375	9.27	– 9.52
C	.125	– .170	3.18	– 4.32	aaa	– .005	–	– 0.127	–
D	.495	– .505	12.57	– 12.83	bbb	– .010	–	– 0.254	–
E	.035	– .045	0.89	– 1.14	ccc	– .015	–	– 0.381	–
F	.003	– .006	0.08	– 0.15	–	–	–	–	–
G	1.100 BSC		27.94 BSC		–	–	–	–	–
H	.057	– .067	1.45	– 1.7	–	–	–	–	–
K	.170	– .210	4.32	– 5.33	–	–	–	–	–
M	.774	– .786	19.66	– 19.96	–	–	–	–	–
N	.772	– .788	19.6	– 20	–	–	–	–	–
Q	∅.118	– ∅.138	∅3	– ∅3.51	–	–	–	–	–
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	STANDARD: NON-JEDEC	
	SOT1793-1	15 MAR 2016

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN
2. GATE
3. SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.805	– .815	20.45	– 20.7	U	–	– .040	–	– 1.02
B	.380	– .390	9.65	– 9.91	Z	–	– .030	–	– 0.76
C	.125	– .170	3.18	– 4.32	aaa	–	.005 –	–	0.127 –
D	.495	– .505	12.57	– 12.83	bbb	–	.010 –	–	0.254 –
E	.035	– .045	0.89	– 1.14	ccc	–	.015 –	–	0.381 –
F	.003	– .006	0.08	– 0.15	–	–	– –	–	– –
H	.057	– .067	1.45	– 1.7	–	–	– –	–	– –
K	.170	– .210	4.32	– 5.33	–	–	– –	–	– –
M	.774	– .786	19.61	– 20.02	–	–	– –	–	– –
N	.772	– .788	19.61	– 20.02	–	–	– –	–	– –
R	.365	– .375	9.27	– 9.53	–	–	– –	–	– –
S	.365	– .375	9.27	– 9.52	–	–	– –	–	– –

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NI–780S

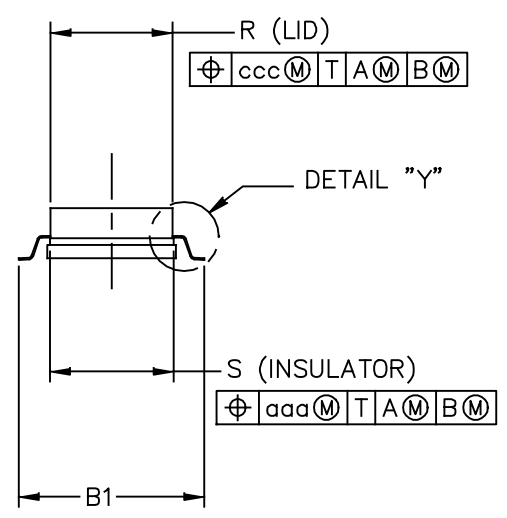
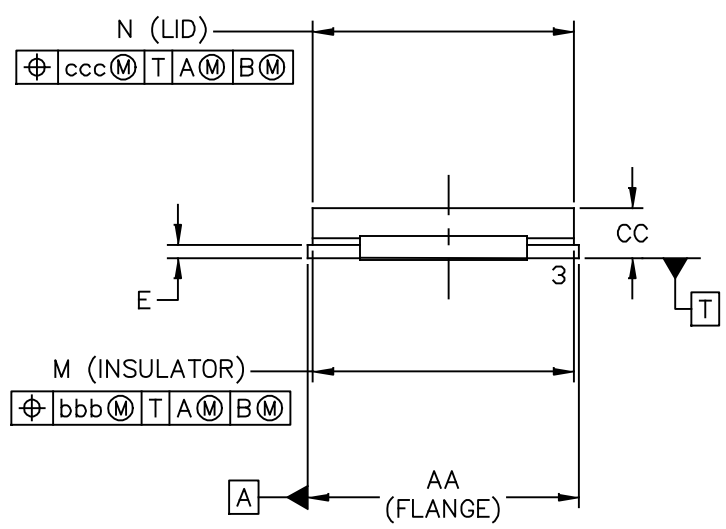
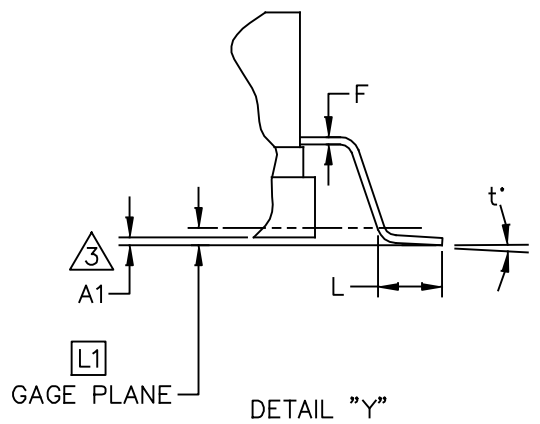
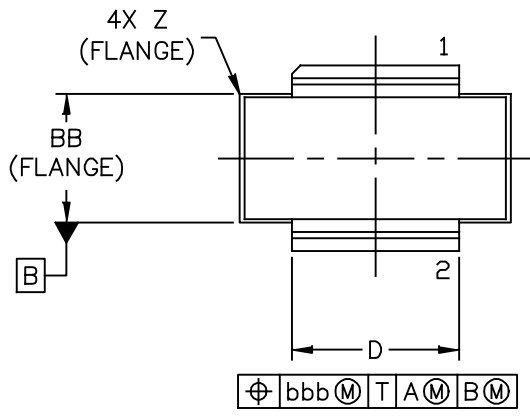
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STANDARD: NON–JEDEC

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15 MAR 2016



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	STANDARD: NON-JEDEC	
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NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.

2. CONTROLLING DIMENSION: INCH.

3. DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM T. THE POSITIVE VALUE IMPLIES THAT THE PACKAGE BOTTOM IS HIGHER THAN THE LEAD BOTTOM.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	.805	.815	20.45	20.70	Z	R.000	R.040	R0.00	R1.02
A1	.002	.008	0.05	0.20	t	0	8	0	8
BB	.380	.390	9.65	9.91					
B1	.546	.562	13.87	14.27					
CC	.125	.170	3.18	4.32	aaa	.005		0.13	
D	.495	.505	12.57	12.83	bbb	.010		0.25	
E	.035	.045	0.89	1.14	ccc	.015		0.38	
F	.003	.006	0.08	0.15					
L	.038	.046	0.97	1.17					
L1	.010 BSC		0.25 BSC						
M	.774	.786	19.66	19.96					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.53					
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TITLE:  NI-780GS-2L					DOCUMENT NO: 98ASA00193D      REV: C				
					STANDARD: NON-JEDEC				
					SOT1802-1		22 FEB 2016		



## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- RF High Power Model

### To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Sept. 2009	<ul style="list-style-type: none"> <li>• Initial Release of Data Sheet</li> </ul>
1	Apr. 2010	<ul style="list-style-type: none"> <li>• Operating Junction Temperature increased from 200°C to 225°C in Maximum Ratings table and related “Continuous use at maximum temperature will affect MTTF” footnote added, p. 1</li> <li>• Added RF High Power Model availability to Product Software, p. 9</li> </ul>
2	Sept. 2010	<ul style="list-style-type: none"> <li>• Maximum Ratings table: corrected <math>V_{DSS}</math> from -0.5, +100 to -0.5, +110 Vdc, p. 2</li> <li>• Added 960-1215 MHz Broadband application as follows:                             <ul style="list-style-type: none"> <li>- Typical Performance, p. 1, 2</li> <li>- Fig. 13, Test Circuit Component Layout and Table 6, Test Circuit Component Designations and Values, p. 8</li> <li>- Fig. 14, Pulsed Power Gain, Drain Efficiency and IRL versus Frequency, p. 9</li> <li>- Fig. 15, Power Gain and Drain Efficiency versus Output Power, p. 9</li> <li>- Fig. 16, Series Equivalent Source and Load Impedance, p. 10</li> </ul> </li> </ul>
3	June 2012	<ul style="list-style-type: none"> <li>• Table 3, ESD Protection Characteristics: added the device’s ESD passing level as applicable to each ESD class, p. 2</li> <li>• Modified figure titles and/or graph axes labels to clarify application use, p. 5, 6, 9</li> <li>• Fig. 6, Output Power versus Input Power: corrected <math>P_{out}</math>, Output Power unit of measure to watts, p. 5</li> <li>• Fig. 9, Output Power versus Input Power: corrected <math>P_{out}</math>, Output Power unit of measure to watts, p. 6</li> <li>• Fig. 11, MTTF versus Junction Temperature: MTTF end temperature on graph changed to match maximum operating junction temperature, p. 6</li> </ul>
4	Mar. 2015	<ul style="list-style-type: none"> <li>• MRF6V12500HR3 tape and reel option replaced with MRF6V12500HR5 and MRF6V12500HSR3 tape and reel option replaced with MRF6V12500HSR5 per PCN15551</li> <li>• Modified figure titles and/or graph axes labels to clarify application use, pp. 6, 7, 9</li> <li>• Typical performance table: added Narrowband Mode S ELM application data, p. 1</li> </ul>
5	July 2016	<ul style="list-style-type: none"> <li>• Added part number MRF6V12500GS, pp. 1, 3</li> <li>• Added NI-780GS-2L package isometric, p. 1, and Mechanical Outline, pp. 15-16</li> </ul>

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